

N-CHANNEL ENHANCEMENT MOS FET

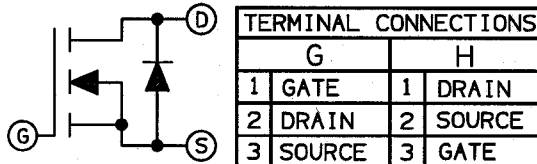
600V, 6.0A, 1.2Ω

SDF6N60 JAA
SDF6N60 JAB

FEATURES

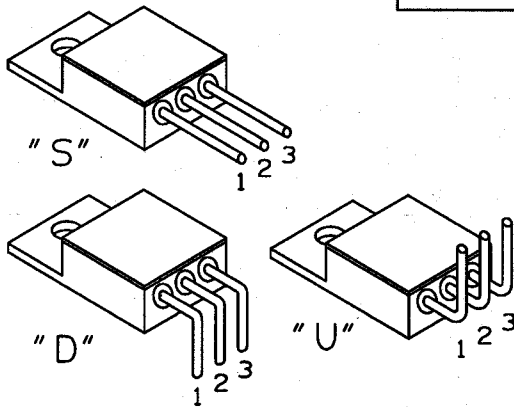
- RUGGED PACKAGE
- HI-REL CONSTRUCTION
- CERAMIC EYELETS
- LEAD BENDING OPTIONS
- COPPER CORED 52 ALLOY PINS
- LOW IR LOSSES
- LOW THERMAL RESISTANCE
- OPTIONAL MIL-S-19500 SCREENING

SCHEMATIC



STANDARD BEND CONFIGURATIONS

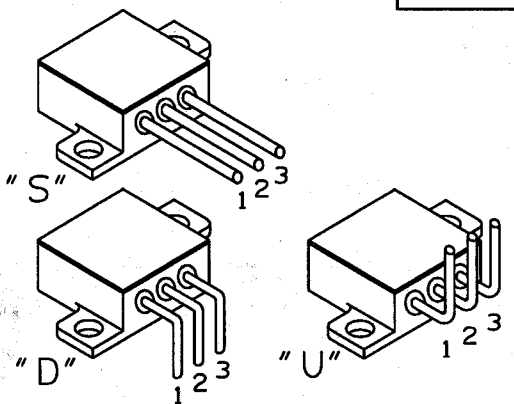
JAA



(CUSTOM BEND OPTIONS AVAILABLE)

STANDARD BEND CONFIGURATIONS

JAB



(CUSTOM BEND OPTIONS AVAILABLE)

ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL		UNITS
Drain-source Volt.(1)	VDSS	600	Vdc
Drain-Gate Voltage (R _{GS} =1.0MΩ) (1)	VDGR	600	Vdc
Gate-Source Voltage Continuous	VGS	±20	Vdc
Drain Current Continuous (T _c = 25°C)	ID	6.0	Adc
Drain Current Pulsed(3)	IDM	24	A
Total Power Dissipation	PD	100	W
Power Dissipation Derating > 25°C		0.83	W/°C
Operating & Storage Temp.	TJ/Tsig	-55 TO +150	°C
Thermal Resistance	RthJc	1.2	°C/W
Max.Lead temperature	TL	300	°C

ELECTRICAL CHARACTERISTICS T_c=25°C (UNLESS OTHERWISE SPECIFIED)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS
Drain-source Breakdown Volt.	V(BR)DSS	VGS=0V ID=250 μA	600	-	-	V
Gate Threshold Voltage	VGS(TH)	VDS=VGS ID=250 μA	2.0	-	4.5	V
Gate Source Leakage	IGSS	VGS=±20 V	-	-	100	nA
Zero Gate Voltage Drain Current	IDSS	VDS=MAX.RATING VGS=0 VDS=0.8 MAX.RATING VGS=0 TJ=125°C	-	-	250	μA
Static Drain-Source On-State Resistance(1)	RDS(ON)	VGS=10 V ID=3.0A	-	-	1.2	Ω
Forward Trans-Conductance (2)	gfs	VDS ≥ 15 V IDS=3.0A	4.5	-	-	S(J)
Input Capacitance	CISS		-	1570	-	pF
Output Capacitance	COSS	VGS=0V VDS=25 V f=1.0 MHz	-	155	-	pF
Reverse Transfer Capacitance	CRSS		-	60	-	pF
Turn-On Delay	td(on)	VDD=300V Zo=10 n ID=3.0A	-	-	35	ns
Rise Time	tr	(MOSFET switching times are essentially independent of operating temp.)	-	-	60	ns
Turn-Off Delay	td(off)		-	-	90	ns
Fall Time	tf		-	-	50	ns
Total Gate Charge (Gate-Source Plus Gate-Drain)	Qg	VGS=10V, ID=6.0A VDS=0.8 MAX.RATING (Gate charge is essentially independent of the operating temperature)	-	-	80	nC
Gate-Source Charge	Qgs		-	-	25	nC
Gate-Drain ("Miller") Charge	Qgd		-	-	30	nC

SOURCE-DRAIN DIODE RATINGS & CHARACT. T_c=25°C (UNLESS OTHERWISE SPECIFIED)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS
Continuous Source Current (Body Diode)	IS	Modified MOSFET symbol showing the integral reverse P-N junction rectifier (See schematic)	-	-	4.0	A
Pulse Source Current (Body Diode) (1)	ISM		-	-	16	A
Diode Forward Voltage (2)	VSD	IF=6.0A VGS=0V Tc=+25°C	-	-	1.5	V
Reverse Recovery Time	trr	Tc=+25° C IF=6.0A di/dt=100A/μS	-	600	-	ns

(1) T_J = 25°C to 150°C.

(2) Pulse test: Pulse Width < 300μS, Duty Cycle < 2%.

(3) Repetitive Rating: Pulse Width Limited By Max. Junction Temperature.